

# Am25LS241 • Am54LS/74LS241 Am25LS244 • Am54LS/74LS244

## Octal Three-State Buffers

### DISTINCTIVE CHARACTERISTICS

- Three-state outputs drive bus lines directly
- Hysteresis at inputs improve noise margin
- PNP inputs reduce D.C. loading on bus lines
- Data-to-output propagation delay times – 18ns MAX.
- Enable-to-output – 30ns MAX.
- Am25LS241 and 244 specified at 48mA output current
- 20 pin hermetic and molded DIP packages
- 100% product assurance testing to MIL-STD-883 requirements

### FUNCTIONAL DESCRIPTION

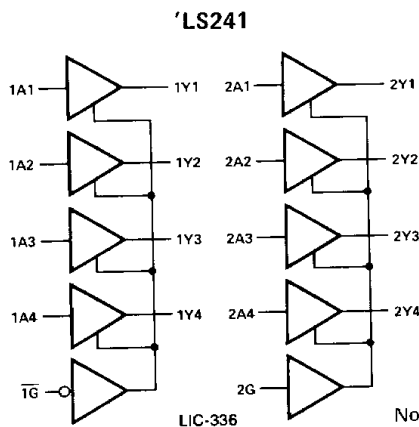
The 'LS241 and 'LS244 are octal buffers fabricated using advanced low-power Schottky technology. The 20-pin package provides improved printed circuit board density for use in memory address and clock driver applications.

Three-state outputs are provided to drive bus lines directly. The Am25LS241 and Am25LS244 are specified at 48mA and 24mA output sink current, while the Am54LS/74LS241 and Am54LS/74LS244 are guaranteed at 12mA over the military range and 24mA over the commercial range. Four buffers are enabled from one common line and the other four from a second enable line.

The 'LS241 has enable inputs of opposite polarity to allow use as a transceiver without overlap. The 'LS244 enables are of similar polarity for use as a unidirectional buffer in which both halves are enabled simultaneously.

Improved noise rejection and high fan-out are provided by input hysteresis and low current PNP inputs.

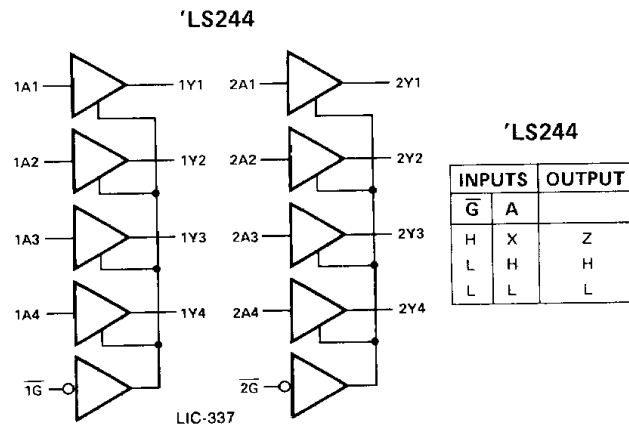
### LOGIC DIAGRAMS



**'LS241**

INPUTS			OUTPUTS
$\overline{1G}$	2G	A	Y
H	L	X	Z
L	H	H	H
L	L	H	L

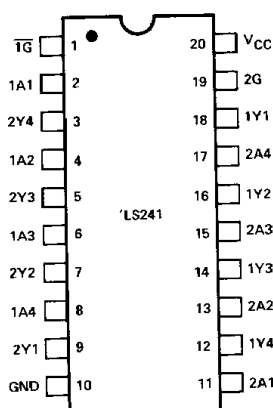
Note: All devices have input hysteresis.



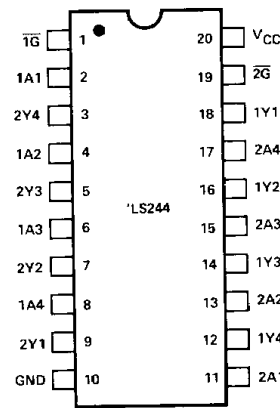
**'LS244**

INPUTS		OUTPUT
$\overline{G}$	A	
H	X	Z
L	H	H
L	L	L

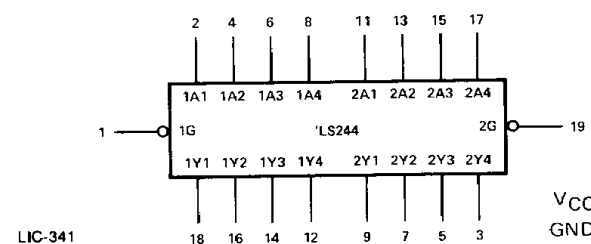
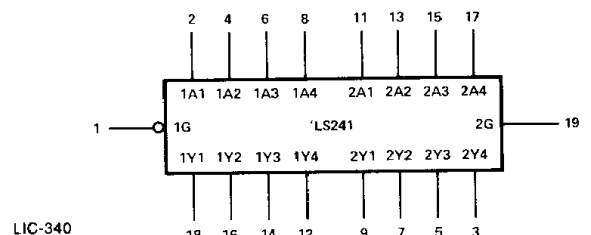
### CONNECTION DIAGRAMS Top Views



Note: Pin 1 is marked for orientation.



### LOGIC SYMBOLS



$V_{CC}$  = Pin 20  
GND = Pin 10

## Am25LS241 • Am25LS244

## ELECTRICAL CHARACTERISTICS

The Following Conditions Apply Unless Otherwise Specified:

COM'L  $T_A = 0^\circ\text{C to } +70^\circ\text{C}$   $V_{CC} = 5.0\text{V} \pm 5\%$  (MIN. = 4.75V MAX. = 5.25V)MIL  $T_A = -55^\circ\text{C to } +125^\circ\text{C}$   $V_{CC} = 5.0\text{V} \pm 10\%$  (MIN. = 4.50V MAX. = 5.50V)

## DC CHARACTERISTICS OVER OPERATING RANGE

Parameters	Description	Test Conditions (Note 1)	Min.	Typ. (Note 2)	Max.	Units	
$V_{OH}$	High-Level Output Voltage	$V_{CC} = \text{MIN.}, V_{IH} = 2.0\text{V}$ $I_{OH} = -3.0\text{mA}, V_{IL} = V_{IL\text{MAX.}}$	2.4	3.4		Volts	
		$V_{CC} = \text{MIN.},$ $V_{IL} = 0.5\text{V}$	MIL, $I_{OH} = -12\text{mA}$	2.0			
			COM'L, $I_{OH} = -15\text{mA}$	2.0			
$V_{OL}$	Low-Level Output Voltage	$V_{CC} = \text{MIN.}$	All $I_{OL} = 12\text{mA}$	0.25	0.4	Volts	
			All $I_{OL} = 24\text{mA}$		0.35		0.5
			COM'L, $I_{OL} = 48\text{mA}$				0.55
$V_{IH}$	High-Level Input Voltage	Guaranteed input logical HIGH voltage for all inputs	2.0			Volts	
$V_{IL}$	Low-Level Input Voltage	COM'L			0.8	Volts	
		MIL			0.7		
$V_{IK}$	Input Clamp Voltage	$V_{CC} = \text{MIN.}, I_I = -18\text{mA}$			-1.5	Volts	
	Hysteresis ( $V_{T+} - V_{T-}$ )	$V_{CC} = \text{MIN.}$	0.2	0.4		Volts	
$I_{OZH}$	Off-State Output Current, High Level Voltage Applied	$V_{CC} = \text{MAX.}$ $V_{IH} = 2.0\text{V}$ $V_{IL} = V_{IL\text{MAX.}}$	$V_O = 2.7\text{V}$		20	$\mu\text{A}$	
$I_{OZL}$	Off-State Output Current, Low-Level Voltage Applied			$V_O = 0.4\text{V}$			-20
$I_I$	Input Current at Maximum Input Voltage	$V_{CC} = \text{MAX.}, V_I = 7.0\text{V}$			0.1	mA	
$I_{IH}$	High-Level Input Current, Any Input	$V_{CC} = \text{MAX.}, V_{IH} = 2.7\text{V}$			20	$\mu\text{A}$	
$I_{IL}$	Low-Level Input Current	$V_{CC} = \text{MAX.}, V_{IL} = 0.4\text{V}$			-200	$\mu\text{A}$	
$I_{SC}$	Short Circuit Output Current (Note 3)	$V_{CC} = \text{MAX.}$	-40		-225	mA	
$I_{CC}$	Supply Current	$V_{CC} = \text{MAX.}$ Outputs open	All Outputs HIGH	13	23	mA	
			All Outputs LOW		27		46
			Outputs at Hi-Z		32		54

Notes: 1. For conditions shown as MIN. or MAX., use the appropriate value specified under recommended operating conditions.

2. All typical values are  $V_{CC} = 5.0\text{V}$ ,  $T_A = 25^\circ\text{C}$ .

3. Not more than one output should be shorted at a time, and duration of the short-circuit should not exceed one second.

## MAXIMUM RATINGS above which the useful life may be impaired

Storage Temperature	-65°C to +150°C
Temperature (Ambient) Under Bias	-55°C to +125°C
Supply Voltage to Ground Potential	-0.5V to +7.0V
IC Voltage Applied to Outputs for HIGH Output State	-0.5V to + $V_{CC}$ max.
IC Input Voltage	-0.5V to +7.0V
IC Output Current	150mA
IC Input Current	-30mA to +5.0mA

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**Am54LS/74LS241 • Am54LS/74LS244**  
**ELECTRICAL CHARACTERISTICS**

The Following Conditions Apply Unless Otherwise Specified:

COM'L  $T_A = 0^\circ\text{C to } +70^\circ\text{C}$   $V_{CC} = 5.0\text{V} \pm 5\%$  (MIN. = 4.75V MAX. = 5.25V)  
 MIL  $T_A = -55^\circ\text{C to } +125^\circ\text{C}$   $V_{CC} = 5.0\text{V} \pm 10\%$  (MIN. = 4.50V MAX. = 5.50V)

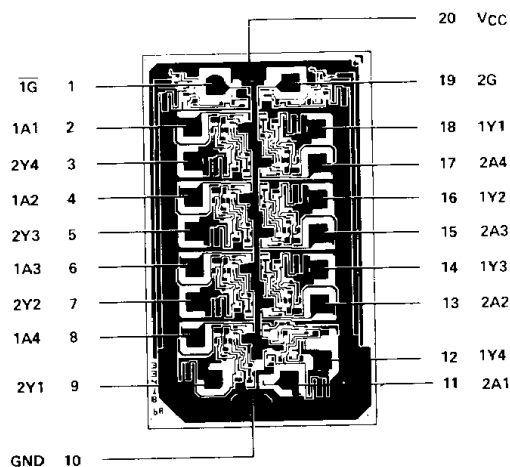
**DC CHARACTERISTICS OVER OPERATING RANGE**

Parameters	Description	Test Conditions (Note 1)	Min.	Typ. (Note 2)	Max.	Units
$V_{OH}$	High-Level Output Voltage	$V_{CC} = \text{MIN.}, V_{IH} = 2.0\text{V}$ $I_{OH} = -3.0\text{mA}, V_{IL} = V_{IL\text{MAX.}}$	2.4	3.4		Volts
		$V_{CC} = \text{MIN.}, V_{IL} = 0.5\text{V}$	MIL, $I_{OH} = -12\text{mA}$ COM'L, $I_{OH} = -15\text{mA}$	2.0		
$V_{OL}$	Low-Level Output Voltage	$V_{CC} = \text{MIN.}$	All, $I_{OL} = 12\text{mA}$	0.25	0.4	Volts
			COM'L, $I_{OL} = 24\text{mA}$	0.35	0.5	
$V_{IH}$	High-Level Input Voltage	Guaranteed input logical HIGH voltage for all inputs	2.0			Volts
$V_{IL}$	Low-Level Input Voltage	COM'L			0.8	Volts
		MIL			0.7	
$V_{IK}$	Input Clamp Voltage	$V_{CC} = \text{MIN.}, I_I = -18\text{mA}$			-1.5	Volts
	Hysteresis ( $V_{T+} - V_{T-}$ )	$V_{CC} = \text{MIN.}$	0.2	0.4		Volts
$I_{OZH}$	Off-State Output Current, High Level Voltage Applied	$V_{CC} = \text{MAX.}, V_{IH} = 2.0\text{V}$ $V_{IL} = V_{IL\text{MAX.}}$	$V_O = 2.7\text{V}$		20	$\mu\text{A}$
$I_{OZL}$	Off-State Output Current, Low-Level Voltage Applied			$V_O = 0.4\text{V}$	-20	
$I_I$	Input Current at Maximum Input Voltage	$V_{CC} = \text{MAX.}, V_I = 7.0\text{V}$			0.1	mA
$I_{IH}$	High-Level Input Current, Any Input	$V_{CC} = \text{MAX.}, V_{IH} = 2.7\text{V}$			20	$\mu\text{A}$
$I_{IL}$	Low-Level Input Current	$V_{CC} = \text{MAX.}, V_{IL} = 0.4\text{V}$			-200	$\mu\text{A}$
$I_{SC}$	Short Circuit Output Current (Note 3)	$V_{CC} = \text{MAX.}$	-40		-225	mA
$I_{CC}$	Supply Current	$V_{CC} = \text{MAX.}$ Outputs open	All Outputs HIGH	13	23	mA
			All Outputs LOW	27	46	
			Outputs at Hi-Z	32	54	

- Notes: 1. For conditions shown as MIN. or MAX., use the appropriate value specified under recommended operating conditions.  
 2. All typical values are  $V_{CC} = 5.0\text{V}, T_A = 25^\circ\text{C}$ .  
 3. Not more than one output should be shorted at a time, and duration of the short-circuit should not exceed one second.

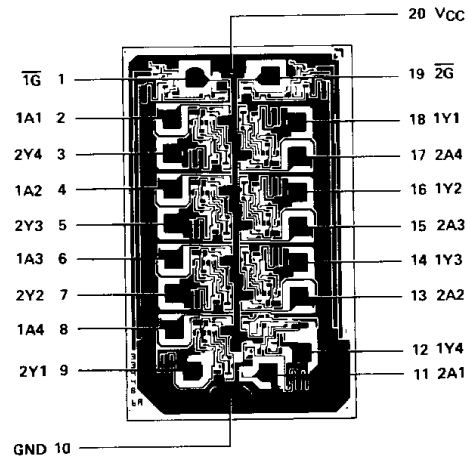
**Metallization and Pad Layouts**

'LS241



DIE SIZE .056" X .089"

'LS244



DIE SIZE .056" X .089"

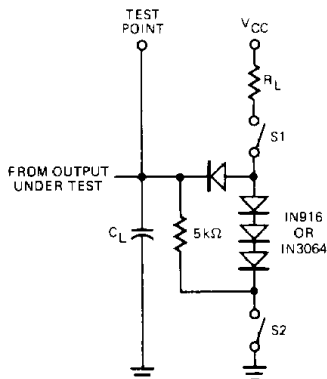
**SWITCHING CHARACTERISTICS** $(T_A = +25^\circ\text{C}, V_{CC} = 5.0\text{V})$ 

Parameters	Description	Am25LS241 Am25LS244			Am54LS/74LS241 Am54LS/74LS244			Units	Test Conditions (Notes 1-5)
		Min.	Typ.	Max.	Min.	Typ.	Max.		
$t_{PLH}$	Propagation Delay Time, Low-to-High-Level Output		10	15		12	18	ns	$C_L = 45\text{pF}$ $R_L = 667\Omega$
$t_{PHL}$	Propagation Delay Time, High-to-Low-Level Output		12	18		12	18	ns	
$t_{PZL}$	Output Enable Time to Low Level		20	30		20	30	ns	
$t_{PZH}$	Output Enable Time to High Level		15	23		15	23	ns	
$t_{PLZ}$	Output Disable Time from Low Level		15	25		15	25	ns	$C_L = 5.0\text{pF}$ $R_L = 667\Omega$
$t_{PHZ}$	Output Disable Time from High Level		10	18		10	18	ns	

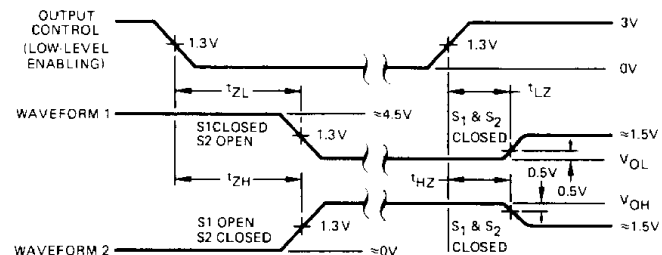
**Am25LS ONLY  
SWITCHING CHARACTERISTICS  
OVER OPERATING RANGE\***

Parameters	Description	Am25LS COM'L		Am25LS MIL		Units	Test Conditions
		Min.	Max.	Min.	Max.		
		$T_A = 0^\circ\text{C to } +70^\circ\text{C}$ $V_{CC} = 5.0\text{V} \pm 5\%$		$T_A = -55^\circ\text{C to } +125^\circ\text{C}$ $V_{CC} = 5.0\text{V} \pm 10\%$			
$t_{PLH}$	Propagation Delay Time, Low-to-High-Level Output		21		24	ns	$C_L = 45\text{pF}$ $R_L = 667\Omega$
$t_{PHL}$	Propagation Delay Time, High-to-Low-Level Output		25		28	ns	
$t_{PZL}$	Output Enable Time to Low Level		41		47	ns	
$t_{PZH}$	Output Enable Time to High Level		31		47	ns	
$t_{PLZ}$	Output Disable Time from Low Level		34		36	ns	$C_L = 5.0\text{pF}$ $R_L = 667\Omega$
$t_{PHZ}$	Output Disable Time from High Level		25		28	ns	

\*AC performance over the operating temperature range is guaranteed by testing defined in Group A, Subgroup 9.

**LOAD CIRCUIT FOR  
THREE-STATE OUTPUTS**

LIC-342

**VOLTAGE WAVEFORMS  
ENABLE AND DISABLE TIMES, THREE-STATE OUTPUTS**

LIC-343

- Notes:
- Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control.
  - Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
  - In the examples above, the phase relationships between inputs and outputs have been chosen arbitrarily.
  - Pulse generator characteristics:  $\text{PRR} \leq 1.0\text{MHz}$ ,  $Z_{\text{OUT}} \approx 50\Omega$ ,  $t_r \leq 15\text{ns}$ ,  $t_f \leq 6\text{ns}$ .
  - When measuring  $t_{PLH}$  and  $t_{PHL}$ , switches  $S_1$  and  $S_2$  are closed.